On the Performance of Fault Screeners in Software Development and Deployment

Rui Abreu, Alberto González, Peter Zoeteweij, and Arjan J.C. van Gemund

Report TUD-SERG-2008-002
On the Performance of Fault Screeners in Software Development and Deployment

Rui Abreu, Alberto González, Peter Zoeteweij, and Arjan J.C. van Gemund

Software Technology Department
Faculty of Electrical Engineering, Mathematics, and Computer Science
Delft University of Technology
P.O. Box 5031, NL-2600 GA Delft, The Netherlands
{r.f.abreu, a.gonzalez-sanchez, p.zoeteweij, a.j.c.vangemund}@tudelft.nl

Keywords: Error detection, program invariants, analytic model, fault localization, program spectra.

Abstract: Fault screeners are simple software (or hardware) constructs that detect variable value errors based on unary invariant checking. In this paper we evaluate and compare the performance of two low-cost screeners (Bloom filter, and range screener) that can be automatically integrated within a program, while being automatically trained during the testing phase. While the Bloom filter has the capacity of retaining virtually all variable values associated with proper program execution, this property comes with a much higher false positive rate per unit training effort, compared to the more simple range screener, that compresses all value information in terms of a single lower and upper bound. We present a novel analytic model that predicts the false positive and false negative rate for both type of screeners. We show that the model agrees with our empirical findings. Furthermore, we describe the application of both screeners, where the screener output is used as input to a fault localization process that provides automatic feedback on the location of residual program defects during deployment in the field.

1 Introduction

In many domains such as consumer products the residual defect rate of software is considerable, due to the trade-off between reliability on the one hand and development cost and time-to-market on the other. Proper error detection is a critical factor in successfully recognizing, and coping with (recovering from) failures during the deployment phase (PBB+KC02; KC03). Even more than during testing at the development phase, errors may otherwise go unnoticed, possibly resulting in catastrophic failure later.

Error detection is typically implemented through tests (invariants) that usually trigger some exception handling process. The invariants range from application-specific (e.g., a user-programmed test to assert that two state variables in two different components are in sync) to generic (e.g., a compiler-generated value range check). While application-specific invariants cover many failures anticipated by the programmer and have a low false positive and false negative rate\(^1\), their (manual) integration within the code is typically a costly, and error-prone process. Despite the simplicity of generic invariants, and their higher false positive and false negative rate, they can be automatically generated within the code, while their application-specific training can also be automatically performed as integral part of the testing process during the development phase. Furthermore, generic invariants correlate to some extent with application-specific invariants. Consequently, violation of the latter is typically preluded by violation of the former type (ECGN99).

In view of the above, attractive properties, generic invariants, often dubbed fault screeners, have long been subject of study in both the software and the hardware domain (see Section 6). Examples include value screeners such as simple bitmask (HL02; RCMM07) and range screeners (HL02; RCMM07), and more sophisticated screeners such as Bloom filters (HL02; RCMM07). In most work the screeners are used for automatic fault detection (AGZvG08) and fault localization (HL02; PRKR03).

In all the above work, the performance of screeners is evaluated empirically. While empirical information is invaluable, no analytical performance models are available that explain why certain screeners outperform other screeners. For example, it is known that, compared to a (sophisticated) Bloom filter, a simple range screener takes less effort to train, but

\(^1\)An error flagged when there is none is called false positive, while missing an error is called false negative.
has worse detection performance (higher false negative rate). Up to now there has been no modeling effort that supports these empirical findings.

In this paper we analytically and empirically investigate the performance of screeners. In particular, we make the following contributions:

- We develop a simple, approximate, analytical performance model that predicts the false positive and false negative rate in terms of the variable domain size and training effort. We derive a model for screeners that store each individual value during training, and another model for range screeners that compress all training information in terms of a single range interval.

- We evaluate the performance of both Bloom filters and range screeners based on instrumenting them within the Siemens benchmark suite, which comprises a large set of program versions, of which a subset is seeded with faults. We show that our empirical findings are in agreement with our model.

- As a typical application of screeners, we show how the Bloom filter and range screeners are applied as input for automatic fault localization, namely spectrum-based fault localization (SFL). It is shown that the resulting fault localization accuracy is comparable to one that is traditionally achieved at the design (testing) phase.

The paper is organized as follows. In the next section we introduce the Bloom filter and range screeners. In Section 3 the experimental setup is described and the empirical results are discussed. Section 4 presents our analytical performance model. The application of screeners as input for SFL is discussed in Section 5. A comparison to related work appears in Section 6. Section 7 concludes the paper.

2 Fault Screeners

Program invariants, first introduced by Ernst et al. (ECGN99) with the purpose of supporting program evolution, are conditions that have to be met by the state of the program for it to be correct. Many kinds of program invariants have been proposed in the past (ECGN99; EPG+07; RCMM07). In this paper, we focus on dynamic range invariants (RCMM07), and Bloom filter invariants (RCMM07), as besides being generic, they require minimal overhead (lending themselves well for application within resource-constrained environments, such as embedded systems).

Range invariants are used to represent the (integer or real) bounds of a program variable. Every time a new value \( v \) is observed, it is checked against the currently valid lower bound \( l \) and upper bound \( u \) according to

\[
\text{violation} = \neg (l < v < u) \quad (1)
\]

If \( v \) is outside the bounds, an error is flagged in error detection mode (deployment phase), while in training mode (development phase) the range is extended according to the assignment

\[
l := \min(l, v) \quad (2)
\]
\[
u := \max(l, v) \quad (3)
\]

Bloom filters (Blo70) are a space-efficient probabilistic data structures used to check if an element is a member of a set. This screener is stricter than the range screeners, as it is basically a compact representation of variable’s entire history.

All variables share the same Bloom filter, which is essentially a bit array (64KB, the size of the filter could be decreased by using a backup filter to prevent saturation (RCMM07)). Each 32-bit value \( v \) and instruction address \( i.a \) are merged into a single 32-bit number \( g \):

\[
g = (v + 2^{16}) \vee (0xFFF \wedge i.a) \quad (4)
\]

where \( \vee \) and \( \wedge \) are bitwise operators, respectively. This number \( g \) is used as input to two hash functions \( (h_1 \text{ and } h_2) \), which index into the Bloom filter \( b \). During training mode, the outputs of the hash functions are used to update the Bloom filter according to the assignment

\[
b[h_1(g)] := 1; b[h_2(g)] := 1 \quad (5)
\]

In detection mode an error is flagged according to

\[
\text{violation} = \neg (b[h_1(g)] \wedge b[h_2(g)]) \quad (6)
\]

3 Experiments

In this section the experimental setup is presented, namely the benchmark set of programs, the workflow of the experiments, and the evaluation metrics. Finally, the experimental results are discussed.

3.1 Experimental Setup

Benchmark set In our study, we use a set of test programs known as the Siemens set (HFGO94). The Siemens set is composed of seven programs. Every single program has a correct version and a set of faulty versions of the same program. The correct version can be used as reference version. Each faulty version contains exactly one fault. Each program also has a
set of inputs that ensures full code coverage. Table 1 provides more information about the programs in the package (for more information see (HFGO94)). Although the Siemens set was not assembled with the purpose of testing fault diagnosis and/or error detection techniques, it is typically used by the research community as the set of programs to test their techniques.

In total the Siemens set provides 132 programs. However, as no failures are observed in two of these programs, namely version 9 of schedule2 and version 32 of replace, they are discarded. Besides, we also discard versions 4 and 6 of print_tokens because the faults in these versions are global variables and the profiling tool used in our experiments does not log the execution of these statements. In summary, we discarded 4 versions out of 132 provided by the suite, using 128 versions in our experiments.

**Workflow of Experiments**

Our approach to study the performance of fault screeners as error detectors in the deployment phase comprises three stages. First, the target program is instrumented to generate program spectra (used by the fault localization technique, see Section 5) and execute the invariants (see Figure 1). To prevent faulty programs to corrupt the logged information, the program invariants and spectra themselves are located in an external component (“Screener”). The instrumentation process is implemented as an optimization pass for the LLVM tool (LA04) in C++ (for details on the instrumentation process see (Gon07)). The program points screened are all memory loads/stores, and function argument and return values.

Second, the program is run for those test cases for which the program passes (its output equals that of the reference version), in which the screeners are operated in training mode. The number of (correct) test cases used to train the screeners is of great importance to the performance of the error detectors at the deployment (detection) phase. In the experiments this number is varied between 5% and 100% of all correct cases (134 and 2666 cases on average, respectively) in order to evaluate the effect of training.

Finally, we execute the program over all test cases (excluding training set), in which the screeners are executed in detection mode.

**Error Detection Evaluation Metrics**

We evaluate the error detection performance of the fault screeners by comparing their output to the pass/fail outcome per program over the entire benchmark set. The (“correct”) pass/fail information is obtained by comparing the output of the faulty program with the reference program.

Let $N_P$ and $N_F$ be the size of the set of passed and failed runs, respectively, and let $F_P$ and $F_N$ be the number of false positives and negatives, respectively. We measure the false positive rate $f_p$ and the false negative rate $f_n$ according to

$$f_p = \frac{F_P}{N_P} \quad (7)$$

$$f_n = \frac{F_N}{N_F} \quad (8)$$

**Table 1: Set of programs used in the experiments**

<table>
<thead>
<tr>
<th>Program</th>
<th>Family Versions</th>
<th>LOC</th>
<th>Test Cases</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>print_tokens</td>
<td>10</td>
<td>489</td>
<td>4115</td>
<td>Lexical Analyzer</td>
</tr>
<tr>
<td>print_tokens2</td>
<td>9</td>
<td>397</td>
<td>2710</td>
<td>Pattern Recognition</td>
</tr>
<tr>
<td>replace</td>
<td>32</td>
<td>507</td>
<td>5542</td>
<td>Priority Scheduler</td>
</tr>
<tr>
<td>schedule2</td>
<td>10</td>
<td>299</td>
<td>2710</td>
<td>Priority Scheduler</td>
</tr>
<tr>
<td>trim</td>
<td>41</td>
<td>174</td>
<td>1608</td>
<td>Altitude Separation</td>
</tr>
<tr>
<td>csi_info</td>
<td>23</td>
<td>398</td>
<td>1052</td>
<td>Information Measure</td>
</tr>
</tbody>
</table>

**3.2 Results**

Figure 2 plots $f_p$ and $f_n$ in percents for range and Bloom filter screeners for different percentages of (correct) test cases used to train the screeners, when instrumenting all program points in the program under analysis. The plots represent the average over all programs, which has negligible variance (between $0 - 0.2\%$ and $3 - 5\%$, for $f_p$ and $f_n$, respectively). From the figure, the following conclusions can be drawn for $f_p$: the more test cases used to train the screeners, the lower $f_p$ (as screeners evolve with the learning process). In addition, it can be seen that Bloom filter screeners learn slower than the range screener. Furthermore, for both screeners $f_n$ rapidly increases, meaning that even after minimal training many errors are already tolerated. This is due to:

- limited detection capabilities: only either single upper/lower bounds or a compact representation of the observed values are stored as screened, i.e., simple and invariants, in contrast to the host of invariants conceivable, based on complex relationships between multiple variables (typically found in application-specific invariants)
- program-specific properties: certain variables exhibit the same values for passed and failed runs, see Section 4. Those cases lead to false negatives.
• limited training accuracy: although the plots indicate that the quantity of pass/fail training input is sufficient, the quality of the input is inherently limited. In a number of cases a (faulty) program error does not result in a failure (i.e., a different output than the correct reference program). Consequently, the screener is trained to accept the error, thus limiting its detection sensitivity.

Due to its strictness, Bloom filter screeners have on the one hand lower \( f_n \) than range screeners. On the other, this strictness increases \( f_p \). In the next section we provide a more theoretic explanation for the observed phenomena.

Because of their simplicity, the evaluated screeners entail minimal computational overhead. On average, the 494 (203.6 variance) program points screened introduced an overhead of 14.2% (4.7% variance) for the range screener, and 46.2% (7.1% variance) was measured for the Bloom filter screener (when all program variable loads/stores and function argument/returns are screened).

4 Analytic Model

In this section we present our analytic screening performance model. First, we derive some main properties that apply without considering the particular properties that (simple) screeners exhibit. Next we focus on the range screener, which is a typical example of a simple screener, and which is amongst the screeners evaluated.

4.1 Concepts and Definitions

Consider a particular program variable \( x \). Let \( P \) denote the set of values \( x \) takes in all \( N_P \) passing runs, and let \( F \) denotes the set of values \( x \) takes in all \( N_F \) failing runs. Let \( T \) denote the set of values recorded during training. Let \( |P|, |F|, |T| \) denote the set sizes, respectively. Screener performance can generally be analyzed by considering the relationship between the three sets \( P, F, \) and \( T \) as depicted in Fig. 3. In the figure we distinguish between five regions, numbered 1 through 5, all of which associate with false positives (fp), false negatives (fn), true positives (tp), and true negatives (tn). For example, values of \( x \) which are within \( P \) (i.e., OK values) but which are (still) outside of the training set \( T \), will trigger a false positive (region 1). Region 3 represents the fact that certain values of \( x \) may occur in both passing runs, as well as failing runs, leading to potential false negatives. Region 4 relates to the fact that for many simple screeners the update due to training with a certain OK value (e.g., in region 2) may also lead to acceptance of values that are exclusively associated with failed runs, leading to false negatives (e.g., an upper bound 10, widened to 15 due to \( x = 15 \), while \( x = 13 \) is associated with a failed run).

4.2 Ideal Screening

In the following we derive general properties of the evolution of the false positive rate \( f_p \) and the false negative rate \( f_n \) as training progresses. For each new value of \( x \) in a passing run the probability \( p \) that \( x \) represents a value that is not already trained equals

\[
p = \frac{|P| - |T|}{|P|} = 1 - \frac{|T|}{|P|} \quad (9)
\]

Note that for ideal screeners region 4 does not exist. Hence \( T \) grows entirely within \( P \). Consequently, the expected growth of the training set is given by

\[
t_k - t_{k-1} = p_{k-1} \quad (10)
\]

where \( t_k \) denotes the expected value of \( |T|, E[|T|] \), at training step \( k \), and \( p_k \) denotes the probability \( p \) at step \( k \). It follows that \( t_k \) is given by the recurrence relation

\[
t_k = \alpha \cdot t_{k-1} + 1 \quad (11)
\]

where \( \alpha = 1 - 1/|P| \). The solution to this recurrence relation is given by

\[
t_k = \frac{\alpha^k - 1}{\alpha - 1} \quad (12)
\]
Consequently

\[ E[|T|] = |P| \left( 1 - (1 - \frac{1}{|P|})^k \right) \quad (13) \]

Thus the fraction of \( T \) within \( P \) initially increases linearly with \( k \), approaching \( P \) in the limit for \( k \to \infty \).

Since in detection mode the false positive rate \( f_p \) equals \( p \), from (9) it follows

\[ f_p = (1 - \frac{1}{|P|})^k \quad (14) \]

Thus the false positive rate decreases with \( k \), approaching a particular threshold after a training effort \( k \) that is (approximately) proportional to \( |P| \). As the false negative rate is proportional to the part of \( T \) that intersects with \( F \) (region 3) it follows that \( f_n \) is proportional to the growth of \( T \) according to

\[ f_n = f \left( 1 - (1 - \frac{1}{|P|})^k \right) \quad (15) \]

where \( f \) denotes the fraction of \( P \) that intersects with \( F \). Thus the false negative rate increases with \( k \), approaching \( f \) in the limit when \( T \) equals \( P \). From the above it follows

\[ f_n = f(1 - f_p) \quad (16) \]

### 4.3 Range Screening

In the following we introduce the constraint that the entire value domain of variable \( x \) available for storage is compressed in terms of only one range, coded in terms of two values \( l \) (lower bound) and \( u \) (upper bound). Despite the potential negative impact on \( f_p \) and \( f_n \) we show that the training effort required for a particular performance is independent of the entire value domain, unlike the above, general (“ideal”) case.

After training with \( k \) values, the range screener bounds have evolved to

\[ l_k = \min_{i=1,...,k} x_i \quad (17) \]

\[ u_k = \max_{i=1,...,k} x_i \quad (18) \]

Since \( x_i \) are samples of \( x \), it follows that \( l_k \) and \( u_k \) are essentially the lowest and highest order statistic (Dav70), respectively, of the sequence of \( k \) variates taken from the (pseudo) random variable \( x \) with a particular probability density function (pdf). The order statistics interpretation allows a straightforward performance analysis when the pdf of \( x \) is known. In the following we treat two cases.

#### 4.3.1 Uniform Distribution

Without loss of generality, let \( x \) be distributed according to a uniform pdf between 0 and \( r \) (e.g., a uniformly distributed index variable with some upper bound \( r \)). From, e.g., (Dav70) it follows that the expected values of \( l_k \) and \( u_k \) are given by

\[ E[l_k] = \frac{1}{k+1} r \quad (19) \]

\[ E[u_k] = \frac{k}{k+1} r \quad (20) \]

Consequently,

\[ E[|T|] = E[u_k] - E[l_k] = \frac{k-1}{k+1} r \quad (21) \]

Since \( |P| = r \), from (9) it follows \((f_p = p)\) that

\[ f_p = 1 - \frac{k-1}{k+1} = \frac{2}{k+1} \quad (22) \]

The analysis of \( f_n \) is similar to the previous section, with the modification that for simple screeners such as the range screener the fraction \( f' \) of \( T \) that intersects with \( F \) is generally greater than the fraction \( f \) for ideal screeners (regions 3 and 4, as explained earlier). Thus,

\[ f_n = f' (1 - f_p) = f' k - \frac{1}{k+1} > f k - \frac{1}{k+1} \quad (23) \]

#### 4.3.2 Normal Distribution

Without loss of generality, let \( x \) be distributed according to a normal pdf with zero mean and variance \( \sigma \) (many variables such as loop bounds are measured to have a near-normal distribution over a series of runs with different input sets (GvG06)). From, e.g., (Gum62) it follows that the expected values of \( l_k \) and \( u_k \) are given by the approximation (asymptotically correct for large \( k \))

\[ E[l_k] = \sigma \sqrt{2 \log(0.4k)} \quad (24) \]

\[ E[u_k] = -\sigma \sqrt{2 \log(0.4k)} \quad (25) \]

Consequently,

\[ E[|T|] = E[u_k] - E[l_k] = 2\sigma \sqrt{2 \log(0.4k)} \quad (26) \]

The false positive rate equals the fraction of the normal distribution’s cumulative density function (cdf) not covered by \( T \). In terms of the normal distribution’s cumulative density function (cdf) it follows

\[ f_p = 1 - \text{erf} \frac{\sigma \sqrt{2 \log(0.4k)}}{\sigma \sqrt{2}} \quad (27) \]

which reduces to

\[ f_p = 1 - \text{erf} \sqrt{\log(0.4k)} \quad (28) \]
Note that, again, $f_p$ is independent of the variance of the distribution of $x$. For the false negative rate it follows

$$f_n = f'(1 - f_p) = f' \operatorname{erf} \sqrt{\log(0.4k)}$$  (29)

### 4.4 Discussion

Both the result for uniform and normal distributions show that the use of range screeners implies that the false positive rate (and, similarly, the false negative rate) can be optimized independent of the size of the value domain. Since the value domain of $x$ can be very large this means that range screeners require much less training than “ideal” screeners to attain bounds that are close to the bounds of $P$. Rather than increasing one value at a time by “ideal” screeners, range screeners can “jump” to a much greater range at a single training instance. The associated order statistics show that $|T|$ approaches $|P|$ regardless their absolute size. For limited domains such as in the case of the uniform pdf the bounds grow very quickly. In the case of the normal pdf the bounds grow less quickly. Nevertheless, according to the model a 1 percent false positive rate can be attained for only a few thousand training runs (few hundred in the uniform case).

The model is in good agreement with our empirical findings (see Figure 2). While exhibiting better $f_p$ performance, the Bloom filter suffers from a less steep learning curve ($f_p$) compared to the range screener. Although it might seem that even the Bloom filter has acceptable performance near the 100 percent mark, this is due to an artifact of the measurement setup. For 100 percent training there are no passing runs available for the evaluation (detection) phase, meaning that there will never be a (correct) value presented to the screener that it has not already been seen during training. Consequently, for the 100 percent mark $f_p$ is zero by definition, which implies that in reality the Bloom filter is expected to exhibit still a non-zero false positive rate after 2666 test cases (in agreement with the model). In contrast, for the range screener it is clearly seen that even for 1066 tests $f_p$ is already virtually zero (again, in agreement with the model).

### 5 Fault Screeners and SFL

In this section we evaluate the performance of the studied fault screeners as error detector input for automatic fault localization tools. Although many fault localization tools exist (CZ05; DLZ05; JH05; LFY’06; RR03; ZHGG05), in this paper we use spectrum-based fault localization (SFL) because it is known to be among the best techniques (JH05; LFY’06).

In SFL, program runs are captured in terms of a spectrum. A program spectrum (HRWY98) can be seen as a projection of the execution trace that shows which parts (e.g., blocks, statements, or even paths) of the program were active during its execution (a so-called “hit spectrum”). In this paper we consider a program part to be a statement. Diagnosis consists in identifying the part whose activation pattern resembles the occurrences of errors in different executions. This degree of similarity is calculated using similarity coefficients taken from data clustering techniques (JD88). Amongst the best similarity coefficients for SFL is the Ochiai coefficient (AZvG07; AGZvG08; AZv06). The output of SFL is a ranked list of parts (statements) in order of likelihood to be at fault.

Given that the output of SFL is a ranked list of statements in order of likelihood to be at fault, we define quality of the diagnosis $q_d$ as $1 - (|p|/(N - 1))$, where $p$ is the position of the faulty statement in the ranking, and $N$ the total number of statements, i.e., the number of statements that need not be inspected when following the ranking in searching for the fault. If there are more statements with the same coefficient, $p$ is then the average ranking position for all of them (see (AGZvG08) for a more elaborate definition).

![Figure 4: Diagnostic quality $q_d$ on average](image)

Figure 4 plots $q_d$ for SFL using either of both screeners versus the training percentage as used in Figure 2. In general, the performance is similar. The higher $f_n$ of the range screener is compensated by its lower $f_p$, compared to the Bloom filter screener. The best $q_d$, 81% for the range screener is obtained for 50% training, whereas the Bloom filter screener has its best 85% performance for 100%. From this, we can conclude that, despite its slower learning curve, the Bloom filter screener can outperform the range screener if massive amounts of data are available for training ($f_p$ becomes acceptable). On the other hand, for those situations where only a few test cases are available, it is better to use the range screener.
Comparing the screener-SFL performance with SFL

![Figure 5: Screener-SFL vs. reference-based SFL]

at development-time (84% on average (AZvG06), see Figure 5), we conclude that the use of screeners in an operational (deployment) context yields comparable diagnostic accuracy to using pass/fail information available in the testing phase. As shown in (AGZvG08) this is due to the fact that the quantity of error information compensates the limited quality.

Due to their small overhead ((AGZvG08; AZvG07), see also Section 3.2), fault screeners and SFL are attractive for being used as error detectors and fault localization, respectively.

6 Related Work

Dynamic program invariants have been subject of study by many researchers for different purposes, such as program evolution (ECGN99; EPG+07; YE04), fault detection (RCMM07), and fault localization (HL02; PRKR03). More recently, they have been used as error detection input for fault localization techniques, namely SFL (AGZvG08).

Daikon (EPG+07) is a dynamic and automatic invariant detector tool for several programming languages, and built with the intention of supporting program evolution, by helping programmers to understand the code. It stores program invariants for several program points, such as call parameters, return values, and for relationships between variables. Examples of stored invariants are constant, non-zero, range, relationships, containment, and ordering. Besides, it can be extended with user-specified invariants. Carrot (PRKR03) is a lightweight version of Daikon, that uses a smaller set of invariants (equality, sum, and order). Carrot tries to use program invariants to pinpoint the faulty locations directly. Similarly to our experiments, the Siemens set is also used to test Carrot. Due to the negative results reported, it has been hypothesized that program invariants alone may not be suitable for debugging. DIDUCE (HL02) uses dynamic bitmask invariants for pinpointing software bugs in Java programs. Essentially, it stores program invariants for the same program points as in this paper. It was tested on four real world applications yielding “useful” results. However, the error detected in the experiments was caused by a variable whose value was constant throughout the training mode and that changed in the deployment phase (hence, easy to detect using the bitmask screener). In (RCMM07) several screeners are evaluated to detect hardware faults. Evaluated screeners include dynamic ranges, bitmasks, TLB misses, and Bloom filters. The authors concluded that bitmask screeners perform slightly better than range and Bloom filter screeners. However, the (hardware) errors used to test the screeners constitute random bit errors which, although ideal for bitmask screeners, hardly occur in program variables. IODINE (HCNC05) is a framework for extracting dynamic invariants for hardware designs. In has been shown that dynamic invariant detection can infer relevant and accurate properties, such as request-acknowledge pairs and mutual exclusion between signals.

To the best of our knowledge, none of the previous work has analytically modeled the performance of the screeners.

7 Conclusions & Future Work

In this paper we have analytically and empirically investigated the performance of low-cost, generic program invariants (also known as “screeners”), namely range and Bloom-filter invariants, in their capacity of error detectors. Empirical results show that near-“ideal” screeners, of which the Bloom filter screener is an example, are slower learners than range invariants, but have less false negatives. As major contribution, we present a novel, approximate, analytical model to explain the fault screener performance. The model shows that the training effort required by near-“ideal” screeners, such as Bloom filters, scales with the variable domain size, whereas simple screeners, such as range screeners, only require constant training effort. Despite its simplicity, the model is in total agreement with the empirical findings. Finally, we evaluated the impact of using such error detectors within an SFL approach aimed at the deployment (operational) phase, rather than just the development phase. We verified that, despite the simplicity of the screeners (and therefore considerable rates of false positives and/or negatives), the diagnostic performance of SFL is similar to the development-time situation. This implies that fault diagnosis with an accuracy comparable to that in the development phase can be attained at the deployment phase with no addi-
tional programming effort or human intervention.

Future work includes the following. Although other screeners are more time-consuming and program-specific, such as relationships between variables, they may lead to better diagnostic performance, and are therefore worth investigating. Furthermore, although earlier work has shown that the current diagnostic metric is comparable to the more common T-score (JH05; RR03), we also plan to redo our study in terms of the T-score, allowing a direct comparison between the use of stand-alone screeners and the screener-SFL approach. Finally, we study ways to decrease screener density, aimed to decrease screening overhead.

REFERENCES


REFERENCES